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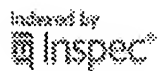
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[Select All](#) [Deselect All](#)**1. Facial action recognition for facial expression analysis from static face images**

Pantic, M.; Rothkrantz, L.J.M.;

[Systems, Man and Cybernetics, Part B, IEEE Transactions on](#)

Volume 34, Issue 3, June 2004 Page(s):1449 - 1461

Digital Object Identifier 10.1109/TSMCB.2004.825931

[AbstractPlus](#) | Full Text: PDF(824 KB) IEEE JNL[Rights and Permissions](#)**2. Facial action detection from dual-view static face images**

Pantic, M.; Rothkrantz, L.;

[Fuzzy Systems, 2004. Proceedings. 2004 IEEE International Conference on](#)

Volume 1, 25-29 July 2004 Page(s):39 - 44 vol.1

[AbstractPlus](#) | Full Text: PDF(1142 KB) IEEE CNF[Rights and Permissions](#)**3. Facial action recognition in face profile image sequences**

Pantic, M.; Patras, I.; Rothkrantz, L.;

[Multimedia and Expo, 2002. ICME '02. Proceedings. 2002 IEEE International Conference on](#)

Volume 1, 26-29 Aug. 2002 Page(s):37 - 40 vol.1

Digital Object Identifier 10.1109/ICME.2002.1035712

[AbstractPlus](#) | Full Text: PDF(495 KB) IEEE CNF[Rights and Permissions](#)**4. A novel neural network technique for the detection of human faces in visual scenes**

Sarris, N.; Grammalidis, N.; Srintzis, M.G.;

[Neural Network Applications in Electrical Engineering, 2000. NEUREL 2000. Proceedings of the 5th Seminar on](#)

25-27 Sept. 2000 Page(s):92 - 96

Digital Object Identifier 10.1109/NEUREL.2000.902391

[AbstractPlus](#) | Full Text: PDF(408 KB) IEEE CNF[Rights and Permissions](#)**5. Automatic extraction of contour lines and feature points from profile images**

Okamoto, N.; Chen, W.; Iida, N.; Minami, T.;

[Electrical and Computer Engineering, 1997. IEEE 1997 Canadian Conference on](#)

Volume 2, 25-28 May 1997 Page(s):831 - 834 vol.2

Digital Object Identifier 10.1109/CCECE.1997.608372

[AbstractPlus](#) | Full Text: PDF(360 KB) IEEE CNF

[Rights and Permissions](#)**6. Face recognition by edge distribution**

Byung-Woo Min; He-Sub Yoon; Jung Soh; Young-Kyu Yang;

[Advanced Intelligent Mechatronics '97 - IEEE/ASME International Conference on](#)

16-20 June 1997 Page(s):27

Digital Object Identifier 10.1109/AIM.1997.652885

[AbstractPlus](#) | Full Text: [PDF](#)(76 KB) [IEEE CNF](#)[Rights and Permissions](#)**7. Self sufficient housing for thle young creatives: Crisis management of the digital entert-producers class**

Ruali, L.; Tesse, M.;

[Intelligent Environments, 2006. IE 06. 2nd IET International Conference on](#)

Volume 2, 5-6 July 2006 Page(s):121 - 129

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